

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of)

Yehiel Gotkis)

Application No. 10/810,209)

Filed: March 26, 2004)

For: METHOD AND APPARATUS FOR)
 MEASUREMENT OF THIN FILMS AND)
 RESIDUES ON SEMICONDUCTOR)
 SYBSTRATES)



Examiner: Unassigned

Art Unit: 1765

Docket No. LAM2P466

Date: September 20, 2004

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450 on September 20, 2004.

Signed: _____

Kay Harlow

Mail Stop: Amendment
 Commissioner for Patents
 P.O. Box 1450
 Alexandria, VA 22313-1450

Sir:

Transmitted herewith is an Amendment in the above-identified application.

The fee has been calculated as shown below.

	Claims Remaining After <u>Amendment</u>	Highest Previously <u>Paid For</u>	Present <u>Extra</u>	SMALL ENTITY <u>RATE FEE</u>	OR	LARGE ENTITY <u>RATE FEE</u>
TOTAL CLAIMS	_____ - _____	_____	_____	X09 = \$	OR	X18 = \$
INDEP CLAIMS	_____ - _____	_____	_____	X43 = \$	OR	X86 = \$
[] Multiple Dependent Claim Present and Fee Not Previously Paid				\$145		\$290
			TOTAL	\$ _____		\$ _____

- ☐ Applicant(s) hereby petition for a _____ month(s) extension of time to respond to the outstanding Office Action.
- ☒ Applicant(s) believe that no (additional) Extension of Time is required; however, if it is determined that such an extension is required, Applicant(s) hereby petition that such an extension be granted and authorize the Commissioner to charge the required fees for an Extension of Time under 37 CFR 1.136 to Deposit Account No. 50-0805.
- ☐ Enclosed is our Check No. _____ in the amount of \$_____ to cover the additional claim fee and/or extension of time fees.
- ☒ If the required fees are missing or any additional fees are required to facilitate filing the enclosed response, please charge such fees or credit any overpayment to Deposit Account No. 50-0805 (Order No.). A copy of this sheet is enclosed.

Respectfully submitted,
 MARTINE & PENILLA, LLP

Albert S. Penilla, Esq.
 Registration No. 39,487

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 Sunnyvale, CA 94085
 Telephone: (408) 749-6900
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 Customer Number 25920



IFW

PATENT

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Signed: _____

Kay Harlow
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AMENDMENT

Mail Stop: Amendment
Honorable Commissioner for Patents
Alexandria VA 22313-1450

Dear Sir:

Please enter this preliminary Amendment before examination.

Amendments to the Drawings begin on page 2 of this paper and include an attached replacement sheet.

Remarks/Arguments begin on page 3 of this paper.